# PCTEST ENGINEERING LABORATORY, INC.



7185 Oakland Mills Road, Columbia, MD 21046 USA Tel. 410.290.6652 / Fax 410.290.6654 http://www.pctestlab.com



# **MEASUREMENT REPORT** FCC Part 15.225 NFC

**Applicant Name:** 

Samsung Electronics Co., Ltd. 129, Samsung-ro, Maetan dong, Yeongtong-gu, Suwon-si Gyeonggi-do 443-742, Korea

**Date of Testing:** 6/10 - 6/22/2015 **Test Site/Location:** PCTEST Lab, Columbia, MD, USA Test Report Serial No.: 0Y1506101151.A3L

FCC ID: A3LSMG928T

APPLICANT: Samsung Electronics Co., Ltd.

**Application Type:** Certification SM-G928T Model(s):

**EUT Type:** Portable Handset

Frequency: 13.56MHz

**FCC Classification:** Low Power Communications Device Transmitter (DXX)

FCC Rule Part(s): FCC Part 15 Subpart C (15.225)

ANSI C63.10-2009, KDB 648474 D03 v01r02 Test Procedure(s):

The device bearing the FCC Identifier specified above has been shown to comply with the applicable technical standards as indicated in the measurement report and has been tested in accordance with the measurement procedures specified in ANSI C63.10-2009 (See Test Report). These measurements were performed with no deviation from the standards. Test results reported herein relate only to the item(s) tested.

I authorize and attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

NVLAP accreditation does not constitute any product endorsement by NVLAP or any agency of the United States Government. This report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.

Randy Ortanez



FCC ID: A3LSMG928T	PCTEST' ENGINEERING LABORATORY, INC.	FCC Pt. 15.225 MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N:	Test Date(s):	EUT Type:		Page 1 of 24
0Y1506101151.A3L	6/10 - 6/22/2015	Portable Handset		Faye 1 01 24



# TABLE OF CONTENTS

FCC	Part 1	5.225 MEASUREMENT REPORT	3
1.0	INT	RODUCTION	4
	1.1	SCOPE	4
	1.2	PCTEST TEST LOCATION	4
2.0	PRO	DDUCT INFORMATION	5
	2.1	EQUIPMENT DESCRIPTION	5
	2.2	DEVICE CAPABILITIES	5
	2.3	TEST CONFIGURATION	5
	2.4	EMI SUPPRESSION DEVICE(S)/MODIFICATIONS	5
3.0	DES	SCRIPTION OF TEST	6
	3.1	EVALUATION PROCEDURE	6
	3.2	AC LINE CONDUCTED EMISSIONS	6
	3.3	RADIATED EMISSIONS	7
	3.4	ENVIRONMENTAL CONDITIONS	7
4.0	AN	TENNA REQUIREMENTS	8
5.0	SAN	MPLE CALCULATIONS	9
	5.1	CONDUCTED EMISSION MEASUREMENT SAMPLE CALCULATION	9
	5.2	RADIATED EMISSION MEASUREMENT SAMPLE CALCULATION	9
6.0	TES	ST EQUIPMENT CALIBRATION DATA	10
7.0	TES	ST DATA	11
	7.1	SUMMARY	11
	7.2	20DB BANDWIDTH MEASUREMENT	12
	7.3	FREQUENCY STABILITY TEST DATA	14
	7.4	IN-BAND RADIATED SPURIOUS EMISSION MEASUREMENTS	16
	7.5	RADIATED SPURIOUS EMISSION MEASUREMENTS, OUT-OF-BAND	17
	7.6	LINE CONDUCTED MEASUREMENT DATA	22
8.0	COI	NCLUSION	24

FCC ID: A3LSMG928T	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 15.225 MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N:	Test Date(s):	EUT Type:		Page 2 of 24
0Y1506101151.A3L	6/10 - 6/22/2015	Portable Handset		Faye 2 01 24





# MEASUREMENT REPORT FCC Part 15.225



## § 2.1033 General Information

Samsung Electronics Co., Ltd. APPLICANT: APPLICANT ADDRESS: 129, Samsung-ro, Maetan dong,

> Yeongtong-gu, Suwon-si Gyeonggi-do 443-742, Korea

PCTEST ENGINEERING LABORATORY, INC. TEST SITE: **TEST SITE ADDRESS:** 7185 Oakland Mills Road, Columbia, MD 21046 USA

FCC RULE PART(S): Part 15 Subpart C (15.225)

**BASE MODEL:** SM-G928T FCC ID: A3LSMG928T

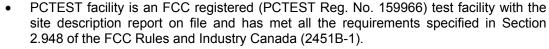
**FCC CLASSIFICATION:** Low Power Communications Device Transmitter (DXX)

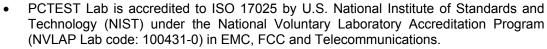
☐ Production ☐ Pre-Production ☐ Engineering **Test Device Serial No.:** 95C02, 966C4

DATE(S) OF TEST: 6/10 - 6/22/2015 **TEST REPORT S/N:** 0Y1506101151.A3L

## **Test Facility / Accreditations**

Measurements were performed at PCTEST Engineering Lab located in Columbia, MD 21046, U.S.A.





- PCTEST Lab is accredited to ISO 17025-2005 by the American Association for Laboratory Accreditation (A2LA) in Specific Absorption Rate (SAR) testing, Hearing Aid Compatibility (HAC) testing, CTIA Test Plans, and wireless testing for FCC and Industry Canada Rules.
- PCTEST Lab is a recognized U.S. Conformity Assessment Body (CAB) in EMC and R&TTE (n.b. 0982) under the U.S.-EU Mutual Recognition Agreement (MRA).
- PCTEST TCB is a Telecommunication Certification Body (TCB) accredited to ISO/IEC Guide 65 by the American National Standards Institute (ANSI) in all scopes of FCC Rules and Industry Canada Standards (RSS).
- PCTEST facility is an IC registered (2451B-1) test laboratory with the site description on file at Industry Canada.
- PCTEST is a CTIA Authorized Test Laboratory (CATL) for AMPS, CDMA, and EvDO wireless devices and for Over-the-Air (OTA) Antenna Performance testing for AMPS, CDMA, GSM, GPRS, EGPRS, UMTS (W-CDMA), CDMA 1xEVDO, and CDMA 1xRTT.





FCC ID: A3LSMG928T	PCTEST	FCC Pt. 15.225 MEASUREMENT REPORT	SAMSUNG	Reviewed by:
FCC ID: A3L3WG9201	ENGINEERING LABORATORY, INC.	(CERTIFICATION)	SKMSONO	Quality Manager
Test Report S/N:	Test Date(s):	EUT Type:		Dago 2 of 24
0Y1506101151.A3L	6/10 - 6/22/2015	Portable Handset		Page 3 of 24



#### INTRODUCTION 1.0

#### 1.1 Scope

Measurement and determination of electromagnetic emissions (EMC) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission and the Industry Canada Certification and Engineering Bureau.

#### 1.2 **PCTEST Test Location**

The map below shows the location of the PCTEST LABORATORY, its proximity to the FCC Laboratory, the Columbia vicinity, the Baltimore-Washington Internt'l (BWI) airport, the city of Baltimore and the Washington, DC area. (See Figure 1-1).

These measurement tests were conducted at the PCTEST Engineering Laboratory, Inc. facility located at 7185 Oakland Mills Road, Columbia, MD 21046. The site coordinates are 39° 10'23" N latitude and 76° 49'50" W longitude. The facility is 0.4 miles North of the FCC laboratory, and the ambient signal and ambient signal strength are approximately equal to those of the FCC laboratory. The detailed description of the measurement facility was found to be in compliance with the requirements of § 2.948 according to ANSI C63.4-2009 on February 15, 2012.

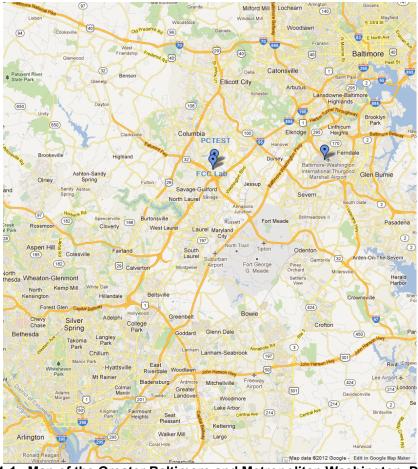


Figure 1-1. Map of the Greater Baltimore and Metropolitan Washington, D.C. area

FCC ID: A3LSMG928T	PCTEST*	FCC Pt. 15.225 MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N:	Test Date(s):	EUT Type:		Dags 4 of 24
0Y1506101151.A3L	6/10 - 6/22/2015	Portable Handset		Page 4 of 24
@ 2015 DCTEST Engineering Laborat	ion. Inc	•		V/20

© 2015 PCTEST Engineering Laboratory, Inc.



## 2.0 PRODUCT INFORMATION

## 2.1 Equipment Description

The Equipment Under Test (EUT) is the **Samsung Portable Handset FCC ID: A3LSMG928T**. The test data contained in this report pertains only to the emissions due to the NFC transmitter of the EUT.

## 2.2 Device Capabilities

This device contains the following capabilities:

850/1900 GSM/GPRS/EDGE, 850/1700/1900 WCDMA/HSPA, Multi-band LTE, 802.11b/g/n WLAN, 802.11a/n/ac UNII, Bluetooth (1x, EDR, LE), NFC, ANT+

The data in this report is taken from FCC ID: A3LSMG928A, whose circuitry is electronically identical to this device.

## 2.3 Test Configuration

The Samsung Portable Handset FCC ID: A3LSMG928T was set to continuously transmit at 13.56MHz. This was performed using manufacturer software loaded on the phone and a passive RFID tag to allow for continuous transmission. This device was tested in accordance with the guidance of ANSI C63.10-2009. See Sections 3.2 and 3.3 of this test report for a description of the AC line conducted emissions and radiated emissions test setups, respectively.

This device supports wireless charging capability and, thus, is subject to the test requirements of KDB 648474 D03 v01r02. Additional radiated spurious emission measurements were performed with the EUT lying flat on a certified wireless charging pad (WCP) while operating under normal conditions in a simulated call or data transmission configuration. The worst case radiated emissions data is shown in this report.

## 2.4 EMI Suppression Device(s)/Modifications

No EMI suppression device(s) were added and no modifications were made during testing.

FCC ID: A3LSMG928T	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 15.225 MEASUREMENT REPORT (CERTIFICATION)	Reviewed by: Quality Manager
Test Report S/N:	Test Date(s):	EUT Type:	Page 5 of 24
0Y1506101151.A3L	6/10 - 6/22/2015	Portable Handset	Fage 5 01 24



## 3.0 DESCRIPTION OF TEST

### 3.1 Evaluation Procedure

The measurement procedure described in the American National Standard for Testing Unlicensed Wireless Devices (ANSI C63.10-2009) was used in the measurement of the **Samsung Portable Handset FCC ID: A3LSMG928T.** 

Deviation from measurement procedure.....None

## 3.2 AC Line Conducted Emissions

The line-conducted facility is located inside a 10'x16'x9' shielded enclosure. The shielded enclosure is manufactured by ETS Lindgren RF Enclosures. The shielding effectiveness of the shielded room is in accordance with MIL-Std-285 or NSA 65-5. A 1m x 1.5m wooden table 80cm high is placed 40cm away from the vertical wall and 80cm away from the sidewall of the shielded room. Two 10kHz-30MHz,  $50\Omega/50\mu$ H Line-Impedance Stabilization Networks (LISNs) are bonded to the shielded room floor. Power to the LISNs is filtered by external high-current high-insertion loss power line filters. The external power line filter is an ETS Lindgren Model LPRX-4X30 (100dB Attenuation, 14kHz-18GHz) and the two EMI/RFI filters are ETS Lindgren Model LRW-2030-S1 (100dB Minimum Insertion Loss, 14kHz – 10GHz). These filters attenuate ambient signal noise from entering the measurement lines. These filters are also bonded to the shielded enclosure.

The EUT is powered from one LISN and the support equipment is powered from the second LISN. If the EUT is a DC-powered device, power will be derived from the source power supply it normally will be powered from and this supply line(s) will be connected to the second LISN. All interconnecting cables more than 1 meter were shortened to a 1 meter length by non-inductive bundling (serpentine fashion) and draped over the back edge of the test table. All cables were at least 40cm above the horizontal reference groundplane. Power cables for support equipment were routed down to the second LISN while ensuring that that cables were not draped over the second LISN.

Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The RF output of the LISN was connected to the spectrum analyzer and exploratory measurements were made to determine the frequencies producing the maximum emission from the EUT. The spectrum was scanned from 150kHz to 30MHz with a spectrum analyzer. The detector function was set to peak mode for exploratory measurements while the bandwidth of the analyzer was set to 10kHz. The EUT, support equipment, and interconnecting cables were arranged and manipulated to maximize each emission. Each emission was also maximized by varying: power lines, the mode of operation or resolution, clock or data exchange speed, scrolling H pattern to the EUT and/or support equipment whichever determined the worst-case emission. Once the worst case emissions have been identified, the one EUT cable configuration/arrangement and mode of operation that produced these emissions is used for final measurements on the same test site. The analyzer is set to CISPR quasi-peak and average detectors with a 9kHz resolution bandwidth for final measurements.

Line conducted emissions test results are shown in Section 7.6. The EMI Receiver mode of the Agilent MXE was used to perform AC line conducted emissions testing.

FCC ID: A3LSMG928T	PCTEST' ENGINEERING LABORATORY, INC.	FCC Pt. 15.225 MEASUREMENT REPORT (CERTIFICATION)	SUNG	Reviewed by: Quality Manager
Test Report S/N:	Test Date(s):	EUT Type:		Page 6 of 24
0Y1506101151.A3L	6/10 - 6/22/2015	Portable Handset		raye 0 01 24
© 2045 DOTEOT Francisco de la laborat	ener lane			1/00



### 3.3 Radiated Emissions

The radiated test facilities consisted of an indoor 3 meter semi-anechoic chamber used for final measurements and exploratory measurements, when necessary. The measurement area is contained within the semi-anechoic chamber which is shielded from any ambient interference. The test site inside the chamber is a 6m x 5.2m elliptical, obstruction-free area in accordance with Clause 5, Figure 5.7 of ANSI C63.4-2009. For measurements above 1GHz absorbers are arranged on the floor between the turn table and the antenna mast in such a way so as to maximize the reduction of reflections. For measurements below 1GHz, the absorbers are removed. An ETS Lindgren Model 2188 raised turntable is used for radiated measurement. It is a continuously rotatable, remote-controlled, metallic turntable and 2 meters (6.56 ft.) in diameter. The turn table is flush with the raised floor of the chamber in order to maintain its function as a ground plane. A 78cm high PVC support structure is placed on top of the turntable. A 3/4" (~1.9cm) sheet of high density polyethylene is used as the table top and is placed on top of the PVC supports to bring the total height of the table to 80cm.

For all measurements, the spectrum was scanned through all EUT azimuths and from 1 to 4 meter receive antenna height using a broadband antenna from 30MHz up to the upper frequency shown in 15.33(b)(1) depending on the highest frequency generated or used in the device or on which the device operates or tunes. For frequencies above 1GHz, linearly polarized double ridge horn antennas were used. For frequencies below 30MHz, a calibrated loop antenna was used. When exploratory measurements were necessary, they were performed at 1 meter test distance inside the semi-anechoic chamber using broadband antennas, broadband amplifiers, and spectrum analyzers to determine the frequencies and modes producing the maximum emissions. Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The test set-up was placed on top of the 0.8 meter high, 1 x 1.5 meter table. The EUT, support equipment, and interconnecting cables were arranged and manipulated to maximize each emission. Appropriate precaution was taken to ensure that all emissions from the EUT were maximized and investigated. The system configuration, clock speed, mode of operation or video resolution, if applicable, turntable azimuth, and receive antenna height was noted for each frequency found.

Final measurements were made in the semi-anechoic chamber using calibrated, linearly polarized broadband and horn antennas. The test setup was configured to the setup that produced the worst case emissions. The spectrum analyzer was set to investigate all frequencies required for testing to compare the highest radiated disturbances with respect to the specified limits. The turntable containing the EUT was rotated through 360 degrees and the height of the receive antenna was varied 1 to 4 meters and stopped at the azimuth and height producing the maximum emission. Each emission was maximized by changing the orientation of the EUT through three orthogonal planes and changing the polarity of the receive antenna, whichever produced the worst-case emissions.

## 3.4 Environmental Conditions

The temperature is controlled within range of 15°C to 35°C. The relative humidity is controlled within range of 10% to 75%. The atmospheric pressure is monitored within the range 86-106kPa (860-1060mbar).

FCC ID: A3LSMG928T	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 15.225 MEASUREMENT REPORT (CERTIFICATION)	Reviewed by: Quality Manager
Test Report S/N:	Test Date(s):	EUT Type:	Dogo 7 of 24
0Y1506101151.A3L	6/10 - 6/22/2015	Portable Handset	Page 7 of 24



# 4.0 ANTENNA REQUIREMENTS

## Excerpt from §15.203 of the FCC Rules/Regulations:

"An intentional radiator antenna shall be designed to ensure that no antenna other than that furnished by the responsible party can be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section."

- The antenna of the Samsung Portable Handset are permanently attached.
- This unit was tested with its standard battery.

### **Conclusion:**

The Samsung Portable Handset FCC ID: A3LSMG928T unit complies with the requirement of §15.203.

FCC ID: A3LSMG928T	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 15.225 MEASUREMENT REPORT (CERTIFICATION)	Reviewed by: Quality Manager
Test Report S/N:	Test Date(s):	EUT Type:	Page 8 of 24
0Y1506101151.A3L	6/10 - 6/22/2015	Portable Handset	rage o oi 24



## 5.0 SAMPLE CALCULATIONS

# 5.1 Conducted Emission Measurement Sample Calculation

## @ 20.3 MHz

Class B limit =  $60.0 \text{ dB}_{\mu}\text{V}$  (Quasi-peak limit)

Reading = - 57.8 dBm (calibrated quasi-peak level)

Convert to  $db\mu V = -57.8 + 107 = 49.2 dB\mu V$ 

Margin =  $49.2 - 60.0 = -10.8 \, dB$ 

= 10.8 dB below limit

# 5.2 Radiated Emission Measurement Sample Calculation

## @ 66.7 MHz

Class B limit =  $100 \mu V/m = 40.0 dB\mu V/m$ 

Reading = -76.0 dBm (calibrated level)

Convert to  $db\mu V$  = -76.0 + 107 = 31.0  $dB\mu V$ 

Antenna Factor + Cable Loss = 5.8 dB/m

Total =  $36.8 \text{ dB}_{\mu}\text{V/m}$ 

Margin =  $36.8 - 40.0 = -3.2 \, dB$ 

= 3.2 dB below limit

## Note:

Level [dB $\mu$ V] = 20 log <sub>10</sub> (Level [ $\mu$ V/m])

Level [dB $\mu$ V] = Level [dBm] + 107

FCC ID: A3LSMG928T	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 15.225 MEASUREMENT REPORT (CERTIFICATION)	Reviewed by: Quality Manager
Test Report S/N:	Test Date(s):	EUT Type:	Page 9 of 24
0Y1506101151.A3L	6/10 - 6/22/2015	Portable Handset	Fage 9 01 24



#### TEST EQUIPMENT CALIBRATION DATA 6.0

Test Equipment Calibration is traceable to the National Institute of Standards and Technology (NIST).

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
-	RE1	Radiated Emissions Cable Set (UHF/EHF)	10/24/2014	Annual	10/24/2015	N/A
Agilent	8447D	Broadband Amplifier	6/12/2015	Annual	6/12/2016	2443A01900
Agilent	N9020A	MXA Signal Analyzer	10/27/2014	Annual	10/27/2015	US46470561
Emco	6502	Active Loop Antenna (10k - 30 MHz)	6/24/2014	Biennial	6/24/2016	267
Espec	ESX-2CA	Environmental Chamber	3/17/2015	Annual	3/17/2016	17620
ETS Lindgren	3117	1-18 GHz DRG Horn (Medium)	4/8/2014	Biennial	4/8/2016	125518
Rohde & Schwarz	ESU26	EMI Test Receiver (26.5GHz)	3/12/2015	Annual	3/12/2016	100342
Sunol	JB5	Bi-Log Antenna (30M - 5GHz)	1/28/2014	Biennial	1/28/2016	A051107

Table 6-1. Annual Test Equipment Calibration Schedule

FCC ID: A3LSMG928T	PCTEST' ENGINEERING LABORATORY, INC.	FCC Pt. 15.225 MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N:	Test Date(s):	EUT Type:		Page 10 of 24
0Y1506101151.A3L	6/10 - 6/22/2015	Portable Handset		Fage 10 01 24



# TEST DATA

#### 7.1 **Summary**

Company Name: Samsung Electronics Co., Ltd.

FCC ID: A3LSMG928T

Low Power Communications Device Transmitter (DXX) FCC Classification:

Frequencies Examined: 13.56MHz

FCC Part Section(s)	Test Description	Test Limit	Test Condition	Test Result	Reference
TRANSMITTER	R MODE (Tx)				
2.1049	20 dB Bandwidth	N/A		PASS	Section 7.2
15.225 (a)(b)(c)	In-Band Emissions	15,848µV/m @ 30m 13.553 – 13.567 MHz 334µV/m @ 30m 13.410 – 13.553 MHz 13.567 – 13.710 MHz 106µV/m @ 30m 13.110 – 13.410 MHz 13.710 – 14.010 MHz	RADIATED	PASS	Section 7.4
15.225 (d) 15.209	Out-of-Band Emissions	Emissions outside of the specified band (13.110 – 14.010 MHz) must meet the radiated limits detailed in 15.209		PASS	Section 7.5
15.225 (e)	Frequency Stability Tolerance	± 0.01% of Operating Frequency	Temperature Chamber	PASS	Section 7.3
15.207	AC Conducted Emissions 150kHz – 30MHz	< FCC 15.207 limits or < RSS-Gen table 2 limits	LINE CONDUCTED	PASS	Section 7.6
RECEIVER MO	DE (Rx) / DIGITAL DEVICE				
15.107	AC Conducted Emissions 150kHz – 30MHz	< FCC 15.107 limits or < RSS-Gen table 2 limits	LINE CONDUCTED	PASS	Part 15B Test Report

Table 7-1. Summary of Test Results

## Note:

This unit was tested with its standard battery.

FCC ID: A3LSMG928T	PCTEST' ENGINEERING LABORATORY, INC.	FCC Pt. 15.225 MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N:	Test Date(s):	EUT Type:		Page 11 of 24
0Y1506101151.A3L	6/10 - 6/22/2015	Portable Handset		Page 110124



#### 20dB Bandwidth Measurement 7.2 §2.1049

The 20dB bandwidth is measured with a spectrum analyzer connected via a receive antenna placed near the EUT while the EUT is operating in transmission mode.

Frequency	20dB Bandwidth	20dB Bandwidth with WCP
13.56MHz	29kHz	657kHz

Table 7-2. 20dB Bandwidth Measurement

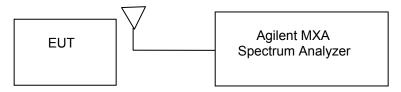


Figure 7-1. Test Instrument & Measurement Setup



Figure 7-2. 20dB Bandwidth Plot

FCC ID: A3LSMG928T	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 15.225 MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N:	Test Date(s):	EUT Type:		Dags 12 of 24
0Y1506101151.A3L	6/10 - 6/22/2015	Portable Handset		Page 12 of 24
@ OOAE DOTEOT Engineering Labor	and a market of the contract o			1/0/





Figure 7-3. 20dB Bandwidth Plot with WCP

FCC ID: A3LSMG928T	PETEST*	FCC Pt. 15.225 MEASUREMENT REPORT (CERTIFICATION)	Reviewed by: Quality Manager
Test Report S/N:	Test Date(s):	EUT Type:	Page 13 of 24
0Y1506101151.A3L	6/10 - 6/22/2015	Portable Handset	Fage 13 01 24



#### **Frequency Stability Test Data** 7.3 §15.225

Part 15.225 requires that devices operating in the 13.553 - 13.567 MHz shall maintain the carrier frequency within 0.01% of the operating frequency over the temperature variation of -20 degrees to +50 degrees C at normal supply voltage.

> **OPERATING FREQUENCY:** 13,560,000 Hz **VDC** REFERENCE VOLTAGE: 3.85 **DEVIATION LIMIT:** % = 1356Hz $\pm 0.01$

VOLTAGE (%)	POWER (VDC)	TEMP (°C)	FREQUENCY (Hz)	Freq. Dev. (Hz)	Deviation (%)
100 %	3.85	+ 20 (Ref)	13,559,816	-184	-0.0013584
100 %		- 30	13,559,974	-26	-0.0001921
100 %		- 20	13,559,951	-49	-0.0003627
100 %		- 10	13,559,808	-192	-0.0014133
100 %		0	13,559,828	-172	-0.0012653
100 %		+ 10	13,559,832	-168	-0.0012422
100 %		+ 20	13,559,940	-60	-0.0004391
100 %		+ 30	13,559,860	-140	-0.0010339
100 %		+ 40	13,559,949	-51	-0.0003763
100 %		+ 50	13,559,995	-5	-0.0000342
BATT. ENDPOINT	3.40	+ 20	13,559,848	-152	-0.0011238

Table 7-3. Frequency Stability Test Data

Test Report S/N: Test Date(s): EUT Type: Page 14 of 24	FCC ID: A3LSMG928T	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 15.225 MEASUREMENT REPORT (CERTIFICATION)	Reviewed by: Quality Manager
	Test Report S/N:	Test Date(s):	EUT Type:	Dogg 14 of 24
0Y1506101151.A3L 6/10 - 6/22/2015 Portable Handset	0Y1506101151.A3L	6/10 - 6/22/2015	Portable Handset	Page 14 01 24



# Frequency Stability Test Data §15.225

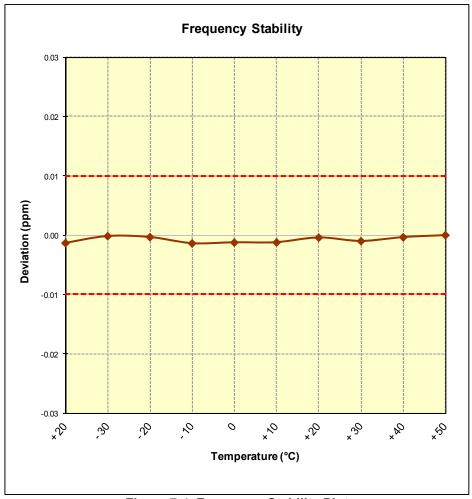


Figure 7-4. Frequency Stability Plot

FCC ID: A3LSMG928T	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 15.225 MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N:	Test Date(s):	EUT Type:		Page 15 of 24
0Y1506101151.A3L	6/10 - 6/22/2015	Portable Handset		Page 15 01 24
@ COAF DOTEOT Facilities Labor				1/06



## **In-Band Radiated Spurious Emission Measurements** §15.225(a)(b)(c)

Radiated emission testing was performed in the band 13.110 – 14.010 MHz.

Frequency: 13.56MHz

Measurement Distance: 3 Meters

Frequency [MHz]	Antenna Position	Level [dBm]	AFCL [dB/m]	3m Field Strength [dBµV/m]	30m Field Strength [dBµV/m]	Limit [µV/m]	Limit [dBµV/m]	Margin [dB]
13.452	Υ	-86.78	10.92	31.14	-8.86	334.00	50.47	-59.33
13.550	Υ	-86.13	10.92	31.79	-8.21	334.00	50.47	-58.68
13.554	Y	-79.17	10.92	38.75	-1.25	15848.00	84.00	-85.25
13.560	Y	-70.43	10.92	47.49	7.49	15848.00	84.00	-76.51
13.567	Y	-79.25	10.92	38.67	-1.33	334.00	50.47	-51.80
13.670	Y	-85.48	10.93	32.45	-7.55	334.00	50.47	-58.03
13.725	Y	-89.84	10.93	28.09	-11.91	106.00	40.51	-52.42

Table 7-4. In-Band Radiated Measurements

### **NOTES:**

- 1. All measurements were performed using a loop antenna. The antenna was positioned in three orthogonal positions (X front, Y side, Z top) and the position with the highest emission level was recorded.
- 2. The EUT was positioned in three orthogonal planes to determine the orientation resulting in the worst case emissions.
- 3. Measurements were performed at 3m and the data was extrapolated to the specified measurement distance of 30m using the square of an inverse linear distance extrapolation factor (40 dB/decade) as specified in §15.31(f)(2). Extrapolation Factor =  $20 \log_{10}(30/3)^2 = 40 \text{dB}$ .
- 4. The spectrum was investigated from 9kHz up to 30MHz using the loop antenna. Only the emissions shown in the table above were found to be significant.
- 5. All measurements were recorded using a spectrum analyzer employing a quasi-peak detector.
- 6. Field Strength Level [dBμV/m] = Analyzer Level [dBm] + 107 + AFCL [dB/m]
- 7. AFCL [dB/m] = Antenna Factor [dB/m] + Cable Loss [dB]
- Margin [dB] = Field Strength Level  $[dB\mu V/m]$  Limit  $[dB\mu V/m]$

FCC ID: A3LSMG928T	PCTEST	FCC Pt. 15.225 MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N:	Test Date(s):	EUT Type:		Page 16 of 24
0Y1506101151.A3L	6/10 - 6/22/2015	Portable Handset		Page 16 01 24
@ COAF DOTEOT Facilities and all ale				1/0/



# 7.5 Radiated Spurious Emission Measurements, Out-of-Band §15.209 §15.225(d)

The EUT was tested from 9kHz up to the 1GHz excluding the band 13.110 – 14.010 MHz. All measurements up to 960MHz were recorded with a spectrum analyzer employing a quasi-peak detector. All out-of-band emissions must not exceed the limits shown in Table 7-5 per Section 15.209. A loop antenna was used to investigate emissions below 30MHz.

Frequency	Field Strength [μV/m]	Measured Distance [Meters]
0.009 – 0.490 MHz	2400/F (kHz)	300
0.490 – 1.705 MHz	24000/F (kHz)	30
1.705 – 30.00 MHz	30	30
30.00 – 88.00 MHz	100	3
88.00 – 216.0 MHz	150	3
216.0 – 960.0 MHz	200	3
Above 960.0 MHz	500	3

Table 7-5. Radiated Limits - Out of band

## **Sample Calculation**

- Field Strength Level [dBμV/m] = Analyzer Level [dBm] + 107 + AFCL [dB/m]
- AFCL [dB/m] = Antenna Factor [dB/m] + Cable Loss [dB]
- o Margin [dB] = Field Strength Level [dB $\mu$ V/m] Limit [dB $\mu$ V/m]

FCC ID: A3LSMG928T	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 15.225 MEASUREMENT REPORT (CERTIFICATION)	Reviewed by: Quality Manager
Test Report S/N:	Test Date(s):	EUT Type:	Dogo 17 of 24
0Y1506101151.A3L	6/10 - 6/22/2015	Portable Handset	Page 17 of 24



# Radiated Spurious Emission Measurements, Out-of-Band §15.209 §15.225(d)

Tx Frequency 13.56MHz

Measurement Distance: 3 Meters

Frequency [MHz]	Ant. Pol. [H/V]	Level [dBm]	AFCL [dB/m]	3m Field Strength [dBµV/m]	Limit [dBµV/m]	Margin [dB]
27.12	Υ	-86.62	9.08	29.46	69.54	-40.08
40.68	٧	-94.66	14.60	26.94	40.00	-13.06
54.24	٧	-99.04	8.70	16.66	40.00	-23.34
67.80	٧	-96.23	8.88	19.65	40.00	-20.35
81.36	٧	-98.15	8.63	17.48	40.00	-22.52
94.92	٧	-93.78	10.04	23.27	43.52	-20.25
108.48	٧	-98.33	13.30	21.97	43.52	-21.56

**Table 7-6. Radiated Measurements** 

## **NOTES:**

- 1. All measurements were recorded using a spectrum analyzer employing a quasi-peak detector for emissions below 960MHz.
- Both Vertical and Horizontal polarities of the receive antenna were evaluated with the worst case emissions being reported. Below 30MHz the loop antenna was positioned in 3 orthogonal planes (X front, Y side, Z top) to determine the orientation resulting in the worst case emissions.
- 3. The EUT was positioned in three orthogonal planes to determine the orientation resulting in the worst case emissions.
- 4. The spectrum is measured from 9kHz to the 10<sup>th</sup> harmonic and the worst-case emissions are reported.
- 5. No spurious emissions levels were found to be greater than the level of the fundamental.

FCC ID: A3LSMG928T	ENGINEERING LABORATORY, INC.	FCC Pt. 15.225 MEASUREMENT REPORT (CERTIFICATION)	Reviewed by: Quality Manager
Test Report S/N:	Test Date(s):	EUT Type:	Page 18 of 24
0Y1506101151.A3L	6/10 - 6/22/2015	Portable Handset	Page 10 01 24



# Radiated Spurious Emission Measurements, Out-of-Band with WCP §15.209 §15.225(d)

Tx Frequency 13.56MHz

Measurement Distance: 3 Meters

Frequency [MHz]	Ant. Pol. [H/V]	Level [dBm]	AFCL [dB/m]	3m Field Strength [dBµV/m]	Limit [dBµV/m]	Margin [dB]
27.12	Υ	-71.09	9.08	44.99	69.54	-24.55
40.68	٧	-84.85	14.60	36.75	40.00	-3.25
54.24	V	-83.29	8.70	32.41	40.00	-7.59
67.80	V	-83.49	8.88	32.39	40.00	-7.61
81.36	V	-83.17	8.63	32.46	40.00	-7.54
94.92	V	-87.97	10.04	29.08	43.52	-14.44
108.48	٧	-98.56	13.30	21.74	43.52	-21.79

Table 7-7. Radiated Measurements with WCP

## **NOTES:**

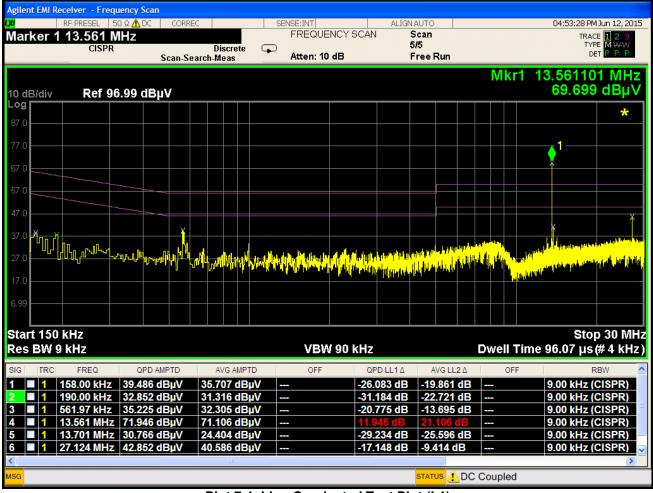
- 1. All measurements were recorded using a spectrum analyzer employing a quasi-peak detector for emissions below 960MHz.
- 2. Both Vertical and Horizontal polarities of the receive antenna were evaluated with the worst case emissions being reported. Below 30MHz the loop antenna was positioned in 3 orthogonal planes (X front, Y side, Z top) to determine the orientation resulting in the worst case emissions.
- 3. The EUT was positioned in three orthogonal planes to determine the orientation resulting in the worst case emissions.
- 4. The spectrum is measured from 9kHz to the 10<sup>th</sup> harmonic and the worst-case emissions are reported.
- 5. No spurious emissions levels were found to be greater than the level of the fundamental.

Test Report S/N: Test Date(s): EUT Type:	FCC ID: A3LSMG928T	SMG928T	FCC Pt. 15.225 MEASUREMENT REPORT (CERTIFICATION)	Reviewed by: Quality Manager
Dags 40 of 9	Test Report S/N:	S/N: Test Date(s):	EUT Type:	Page 19 of 24
0Y1506101151.A3L 6/10 - 6/22/2015 Portable Handset	0Y1506101151.A3L	51.A3L 6/10 - 6/22/2015	Portable Handset	Fage 19 01 24



## 7.6 Line Conducted Measurement Data





Plot 7-1. Line-Conducted Test Plot (L1)

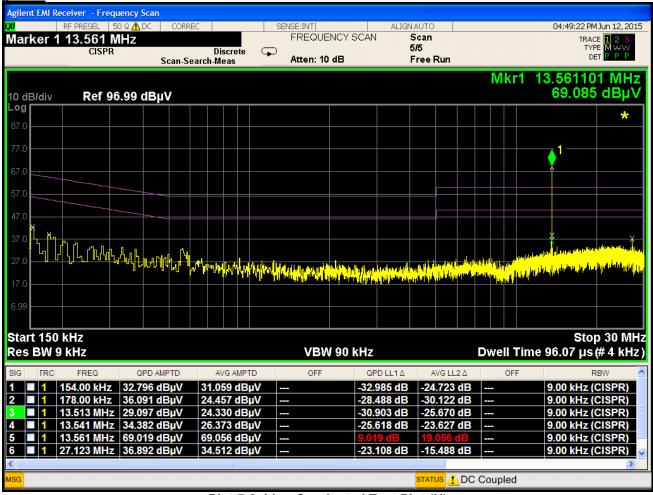
- 1. All modes of operation were investigated and the worst-case emissions are reported.
- 2. The limit for Class B device(s) from 150kHz to 30MHz are specified in Section 15.207 of the Title 47 CFR.
- 3. Corr. (dB) = Cable loss (dB) + LISN insertion factor (dB)
- 4. QP/AV Level (dB $\mu$ V) = QP/AV Analyzer/Receiver Level (dB $\mu$ V) + Corr. (dB)
- 5. Margin (dB) = QP/AV Limit (dB $\mu$ V) QP/AV Level (dB $\mu$ V)
- 6. Traces shown in plot are made using a peak detector.
- 7. Deviations to the Specifications: None.

Test Report S/N: Test Date(s): EUT Type:  0Y1506101151 A3I	FCC ID: A3LSMG928T	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 15.225 MEASUREMENT REPORT (CERTIFICATION)	Reviewed by: Quality Manager
0Y1506101151 A3I 6/10 - 6/22/2015 Portable Handset	Test Report S/N:	Test Date(s):	EUT Type:	Dags 20 of 24
0110001011313.0E 0110 012212010 IT Ortable Harladet	0Y1506101151.A3L	6/10 - 6/22/2015	Portable Handset	Page 20 01 24



## **Line Conducted Measurement Data**

#### §15.207



Plot 7-2. Line-Conducted Test Plot (N)

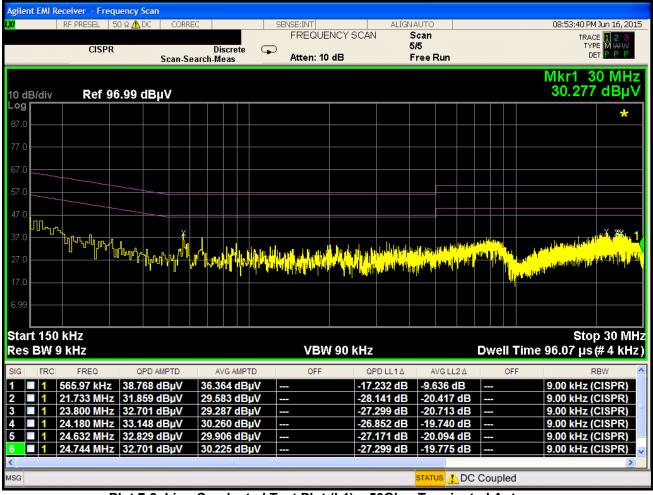
- All modes of operation were investigated and the worst-case emissions are reported.
- 2. The limit for Class B device(s) from 150kHz to 30MHz are specified in Section 15.207 of the Title 47 CFR.
- 3. Corr. (dB) = Cable loss (dB) + LISN insertion factor (dB)
- 4. QP/AV Level (dB $\mu$ V) = QP/AV Analyzer/Receiver Level (dB $\mu$ V) + Corr. (dB)
- Margin (dB) = QP/AV Limit (dB $\mu$ V) QP/AV Level (dB $\mu$ V)
- Traces shown in plot are made using a peak detector. 6.
- Deviations to the Specifications: None.

FCC ID: A3LSMG928T	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 15.225 MEASUREMENT REPORT (CERTIFICATION)	Reviewed by: Quality Manager
Test Report S/N:	Test Date(s):	EUT Type:	Page 21 of 24
0Y1506101151.A3L	6/10 - 6/22/2015	Portable Handset	Page 21 01 24



## **Line Conducted Measurement Data**

#### §15.207



Plot 7-3. Line-Conducted Test Plot (L1) - 500hm Terminated Antenna

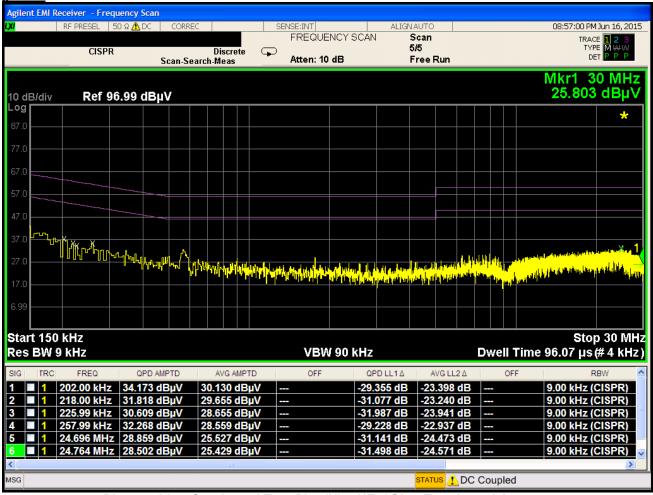
- All modes of operation were investigated and the worst-case emissions are reported.
- 2. The limit for Class B device(s) from 150kHz to 30MHz are specified in Section 15.207 of the Title 47 CFR.
- 3. Corr. (dB) = Cable loss (dB) + LISN insertion factor (dB)
- 4. QP/AV Level (dB $\mu$ V) = QP/AV Analyzer/Receiver Level (dB $\mu$ V) + Corr. (dB)
- Margin (dB) = QP/AV Limit (dB $\mu$ V) QP/AV Level (dB $\mu$ V)
- Traces shown in plot are made using a peak detector.
- Deviations to the Specifications: None.

FCC ID: A3LSMG928T	ENGINEERING LABORATORY, INC.	(CERTIFICATION)	Quality Manager
Test Report S/N:	Test Date(s):	EUT Type:	Page 22 of 24
0Y1506101151.A3L	6/10 - 6/22/2015	Portable Handset	Fage 22 01 24



## **Line Conducted Measurement Data**

#### §15.207



Plot 7-4. Line-Conducted Test Plot (N) - NF500hm Terminated Antenna

- 1. All modes of operation were investigated and the worst-case emissions are reported.
- 2. The limit for Class B device(s) from 150kHz to 30MHz are specified in Section 15.207 of the Title 47 CFR.
- 3. Corr. (dB) = Cable loss (dB) + LISN insertion factor (dB)
- 4. QP/AV Level (dB $\mu$ V) = QP/AV Analyzer/Receiver Level (dB $\mu$ V) + Corr. (dB)
- 5. Margin (dB) = QP/AV Limit (dB $\mu$ V) QP/AV Level (dB $\mu$ V)
- 6. Traces shown in plot are made using a peak detector.
- 7. Deviations to the Specifications: None.

FCC ID: A3LSMG928T	PETEST ENGINEERING LABORATORY, INC.	FCC Pt. 15.225 MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N:	Test Date(s):	EUT Type:		Page 23 of 24
0Y1506101151.A3L	6/10 - 6/22/2015	Portable Handset		Fage 23 01 24



#### CONCLUSION 8.0

The data collected relate only to the item(s) tested and show that the Samsung Portable Handset FCC ID: A3LSMG928T has been tested to show compliance with the requirements specified in §15.225 of the FCC Rules.

FCC ID: A3LSMG928T	PCTEST' ENGINEERING LABORATORY, INC.	FCC Pt. 15.225 MEASUREMENT REPORT (CERTIFICATION)	Reviewed by: Quality Manager
Test Report S/N:	Test Date(s):	EUT Type:	Page 24 of 24
0Y1506101151.A3L	6/10 - 6/22/2015	Portable Handset	1 age 24 01 24